Notice of References Cited Application/Control No. 10/521,955 Examiner Zeev Kitov Applicant(s)/Patent Under Reexamination BOUCHER, CRAIG J. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | Α | US-6,192,802 | 02-2001 | Baginski, Thomas A. | 102/202.2 |
| * | В | US-5,877,927 | 03-1999 | Parat et al. | 361/56 |
| * | С | US-6,501,632 | 12-2002 | Avery et al. | 361/111 |
| | D | US- | | | |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|----------|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| <u> </u> | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | · |
| | Τ | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | The Authoritative Dictionary of IEEE Standard Terms, 2000, IEEE Press, pp. 1234. |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.